Application No. 10/576,486 Paper Dated: June 26, 2008

In Reply to USPTO Correspondence of March 26, 2008

Attorney Docket No. 0388-061179

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application No.

10/576,486

Confirmation No.

6114

Applicant

: Chie Ishikawa et al.

Filed

December 21, 2006

Title

SURFACE DEFECT INSPECTING METHOD AND

**DEVICE** 

Group Art Unit

2877

Examiner

Iyabo S. Alli

Customer No.

28289

Mail Stop Amendment Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

## **AMENDMENT**

Sir:

In response to the Office Action dated March 26, 2008, Applicants submit the following amendments and remarks.

Amendments to the Claims which begin on page 2 of this paper.

Remarks which begin on page 7 of this paper.

I hereby certify that this correspondence is being electronically submitted to the United States Patent and Trademark Office on June

26, 2008.

06/26/2008 Date

/ Signature

Mary Ann Mulvihill

Typed Name of Person Signing Certificate